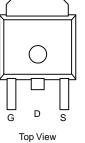


RoHS COMPLIANT

N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^{a, e}	Q _g (Typ)			
40	0.013 at V_{GS} = 10 V	55	42 nC			
40	0.018 at V_{GS} = 4.5 V	45	42 110			



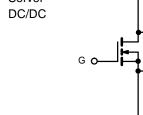


FEATURES

- TrenchFET[®] Power MOSFET
- 100 % R_g and UIS Tested
 Compliant to RoHS Directive 2011/65/EU

APPLICATIONS

- OR-ing
- Server



N-Channel MOSFET

D

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ABSOLUTE MAXIMUM RATINGS	$\mathbf{J}(\mathbf{I}_{A} = 25 \text{ O}, \text{unite})$				
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	40	v		
Gate-Source Voltage		V _{GS}	± 20	v	
	T _C = 25 °C		55 ^{a, e}		
Continuous Drain Current (T _{.1} = 175 °C)	T _C = 70 °C		45 ^e		
Continuous Diairi Current (1j = 175°C)	T _A = 25 °C	I _D	15.8 ^{b, c}	A	
	T _A = 70 °C		12 ^{b, c}		
Pulsed Drain Current	I _{DM}	200			
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	39		
Single Pulse Avalanche Energy	L = 0.1 MH	E _{AS}	94.8	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	۱ _S	90 ^{a, e}	A	
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	3.13 ^{b, c}	A	
	T _C = 25 °C		100 ^a		
Maximum Dawar Dissinction	T _C = 70 °C	P _D	75	w	
Maximum Power Dissipation	T _A = 25 °C	' D	3.75 ^{b, c}	VV	
	T _A = 70 °C		2.63 ^{b, c}		
Operating Junction and Storage Temperature Ra	ange	T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	$t \le 10 \text{ sec}$	R _{thJA}	32	40	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5	0.6	0,00	

Notes:

a. Based on $T_C = 25 \text{ °C}$. b. Surface mounted on 1" x 1" FR4 board.

a. t = 10 sec.
d. Maximum under steady state conditions is 90 °C/W.
e. Calculated based on maximum junction temperature. Package limitation current is 90 A.

9465BGH



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static						1	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$	40			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 250 4		35		m\//00	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 7.5		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	1.5		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zana Cata Maltana Duain Cumant	1	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}$			1	μA	
Zero Gate Voltage Drain Current	IDSS	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 \text{ °C}$			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, \text{ V}_{GS} = 10 \text{ V}$	90			А	
		V _{GS} = 10 V, I _D = 38.8 A		0.012		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, \text{ I}_{D} = 37 \text{ A}$		0.014			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 38.8 A		160		S	
Dynamic ^b	I						
Input Capacitance	C _{iss}			1801			
Output Capacitance	C _{oss}	V_{DS} = 15 V, V_{GS} = 0 V, f = 1 MHz		725		pF	
Reverse Transfer Capacitance	C _{rss}			570			
Total Gate Charge	0	V_{DS} = 15 V, V_{GS} = 10 V, I_{D} = 38.8 A		85	120		
	Qg	Q _g		42	62	nC	
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 28.8 A		17			
Gate-Drain Charge	Q _{gd}			14			
Gate Resistance	Rg	f = 1 MHz		1.4	2.1	Ω	
Turn-On Delay Time	t _{d(on)}			10	20		
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		11	17	- ns	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong$ 24 A, V_{GEN} = 10 V, R_g = 1 Ω		35	55		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			25	43		
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.67 Ω		80	150		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ 22.5 A, V_GEN = 4.5 V, R_g = 1 Ω		26	42		
Fall Time	t _f			12	18	1	
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	۱ _S	T _C = 25 °C			120	٨	
Pulse Diode Forward Current ^a	I _{SM}				120	A	
Body Diode Voltage	V _{SD}	I _S = 22 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _{.I} = 25 °C		70.2	105	nC	
Reverse Recovery Fall Time	t _a	$r_F = 20 \text{ A}, \text{ al/al} = 100 \text{ A/}\text{µs}, r_J = 25 \text{ °C}$		27			
Reverse Recovery Rise Time	t _b			25		ns	

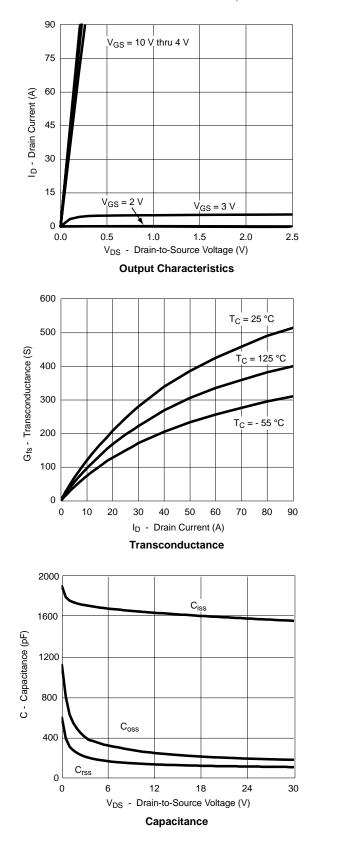
Notes:

a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle ≤ 2 %.

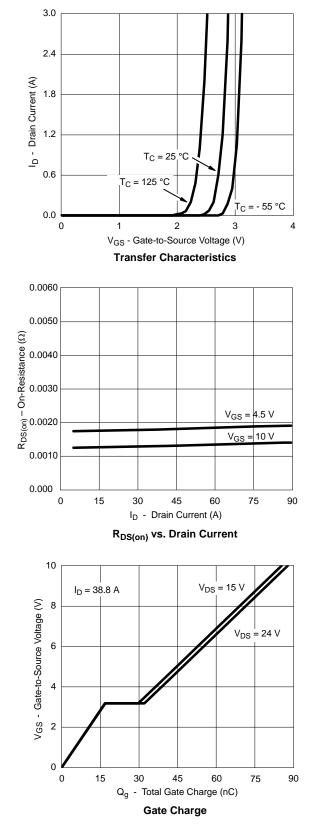
b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)





T_J = 25['] °C

0.8

125 150

175

1

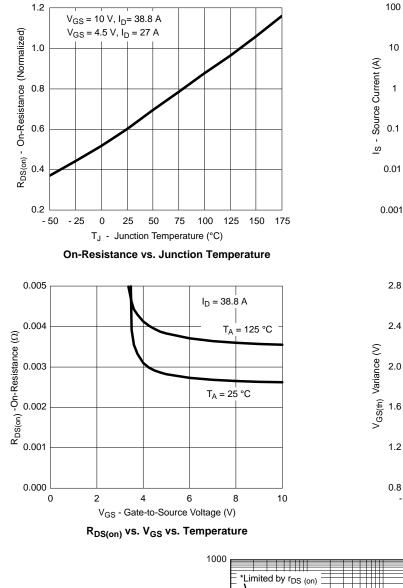
0.6

I_D = 250 μA

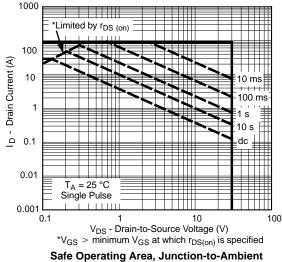
0.4

 V_{SD} - Source-to-Drain Voltage (V)

Forward Diode Voltage vs. Temperature



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



10

1

0

1.6

1.2

- 50 - 25

0

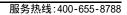
25 50 75 100

T_J - Temperature (°C)

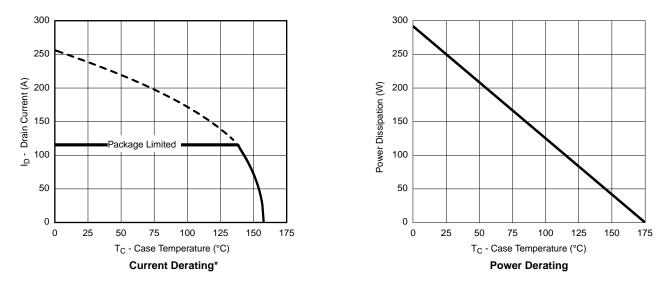
Threshold Voltage

T_J = 150 °C

0.2

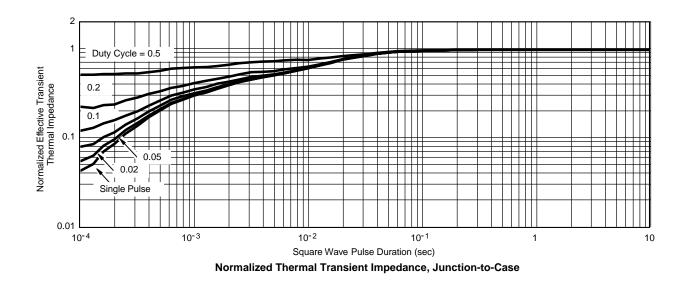






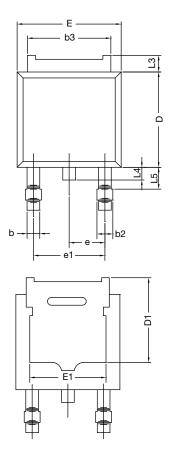
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

*The power dissipation P_D is based on $T_{J(max)} = 175$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





TO-252AA CASE OUTLINE





	MILLIN	IETERS	INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
Е	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28 BSC		0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12- DWG: 534	0247-Rev. M, 7	24-Dec-12			

Note

• Dimension L3 is for reference only.



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